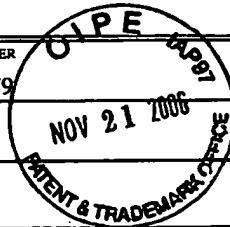


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U.S. Department of Commerce Patent and Trademark Office	APPLICANT TANAKA, et. al.	
Information Disclosure Statement by Applicant	FILING DATE April 21, 2006	GROUP



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Examiner Initial	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
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/SA/	05-262958	27/09/1993	Japan			Abstract	X
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/SA/	International Search Report.
EXAMINER	/Sheeba Ahmed/
DATE CONSIDERED	03/30/2008
<p>EXAMINER: Initial if citation is considered, whether or not citation is in conformance with MPEP 609; draw a line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant</p>	

PTO1449